APPLICANT: Seishi MURAKAMI	T UNIT BA	_
APPLICANT: Seishi MURAKAMI FILING DATE June 13, 2007	T UNIT BA LING DATE,	_
Seishi MURAKAMI	BA	
U.S. PATENT DOCUMENTS	BA	
U.S. PATENT DOCUMENTS	LING DATE,	
DOCUMENT NUMBER NAME CLASS SUB- FOLASS IF /		
Number		
AB 5,895,267 April 20, 1999 Zhao et al. AC 2002/0064598 May 30, 2002 WANG et al. AD 2004/0235191 November 25, 2004 Hasegawa, Toshio AE AF AG FOREIGN PATENT DOCUMENTS FOREIGN PATENT DOCUMENTS Examiner's Initials AH 03/021650 3/13/2003 WO AI AJ AJ AA	PPROPRIAT	
AC 2002/0064598 May 30, 2002 WANG et al. AD 2004/0235191 November 25, 2004 Hasegawa, Toshio AE AF AG FOREIGN PATENT DOCUMENTS Examiner's Initials AH 03/021650 3/13/2003 WO AI AJ AJ AJ AA AK AL AL AM AA AN AN AN AN AN AN AP AP		
AD 2004/0235191 November 25, 2004 Hasegawa, Toshio		
AE		
AF		
AG		
FOREIGN PATENT DOCUMENTS DOCUMENT DATE COUNTRY CLASS SUBCLASS TI CLASS TI CLA		
Examiner's DOCUMENT NUMBER NUMB		
Examiner's Initials DOCUMENT NUMBER DATE COUNTRY CLASS SUBCLASS TI CLASS AH 03/021650 3/13/2003 WO		
Initials		
AI	RANSLATION YES NO	
AJ		
AK		
AL		
AM		
AN AO AP		
AO AP		
AP		
OTHER INFORMATION (Including Author, Title, Date, Pertinent Pages, Etc.)		
AQ Supplementary European Search Report (Application No. EP 04 80 7927)		
AR		
AS .		
EXAMINER: DATE CONSIDERED:		
DATE GONOIDENED.		
*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through the conformance and not considered. Include copy of this form with next communication to applicant.	gh citation if	ı if